International Rectifier

POWER MOSFET SURFACE MOUNT(SMD-1)

Product Summary

Part Number	RDS(on)	ΙD	
IRFN140	0.077Ω	28A	

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

IRFN140 JANTX2N7218U JANTXV2N7218U REF:MIL-PRF-19500/596 100V, N-CHANNEL

HEXFET® MOSFETTECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Surface Mount
- Dynamic dv/dt Rating
- Light-weight

Absolute Maximum Ratings

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	28	
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	20	Α
I _{DM}	Pulsed Drain Current ①	112	
P _D @ T _C = 25°C	Max. Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	250	mJ
IAR	Avalanche Current ①	28	Α
EAR	Repetitive Avalanche Energy ①	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt 3	5.5	V/ns
ТЈ	Operating Junction	-55 to 150	
TSTG	Storage Temperature Range		°C
	Package Mounting Surface Temperature	300(for 5 seconds)	
	Weight	2.6 (Typical)	g

For footnotes refer to the last page

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	,				•	
	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	100	_	_	V	VGS = 0V, ID = 1.0mA
ΔBVDSS/ΔTJ	Temperature Coefficient of Breakdown Voltage	_	0.13	_	V/°C	Reference to 25°C, I _D = 1.0mA
RDS(on)	Static Drain-to-Source On-State	_	_	0.077	Ω	VGS = 10V, ID = 20A (4)
	Resistance	_	_	0.125	32	VGS = 10V, ID = 28A
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	V _{DS} = V _{GS} , I _D = 250μA
9fs	Forward Transconductance	9.0	_	_	S (7)	V _{DS} > 15V, I _{DS} = 20A ④
IDSS	Zero Gate Voltage Drain Current	_	_	25	μА	V _{DS} = 80V ,V _{GS} =0V
		_	_	250	μΑ	V _{DS} = 80V,
						VGS = 0V, TJ = 125°C
IGSS	Gate-to-Source Leakage Forward	_	_	100	1	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse	_	_	-100	nA	V _{GS} = -20V
Qg	Total Gate Charge	_	_	59		VGS =10V, ID = 28A
Qgs	Gate-to-Source Charge	_	_	12	nC	V _{DS} = 50V
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	_	30.7		
td(on)	Turn-On Delay Time	_	_	21		$V_{DD} = 50V, I_{D} = 28A,$
tr	Rise Time	_	_	105		$V_{GS} = 10V, R_{G} = 9.1\Omega$
td(off)	Turn-Off Delay Time	_	_	64	ns	
tf	Fall Time	_	_	65		
LS+LD	Total Inductance	_	4.0	_	nH	Measured from the center of drain pad to
						center of source pad.
Ciss	Input Capacitance		1600	_		VGS = 0V, VDS = 25V
Coss	Output Capacitance	_	550	_	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance		120	_		

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions	
Is	Continuous Source Current ((Body Diode)		_	28			
ISM	Pulse Source Current (Body	Diode) ①	-	_	112	Α		
VSD	Diode Forward Voltage		-	_	1.5	V	$T_j = 25$ °C, $I_S = 28A$, $V_{GS} = 0V$ ④	
trr	Reverse Recovery Time		-	_	400	nS	Tj = 25°C, IF = 28A, di/dt ≤ 100A/μs	
QRR	Reverse Recovery Charge			_	2.9	μC	V _{DD} ≤ 30V ④	
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by L _S + L _D .						

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	-	_	1.0	°C/W	
R _{th} J-PCB	Junction-to-PC board	_	4.0	_	C/VV	Soldered to a copper-clad PC board

Note: Corresponding Spice and Saber models are available on the G&S Website.

For footnotes refer to the last page

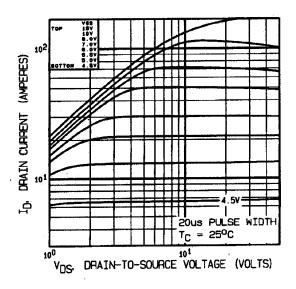


Fig 1. Typical Output Characteristics

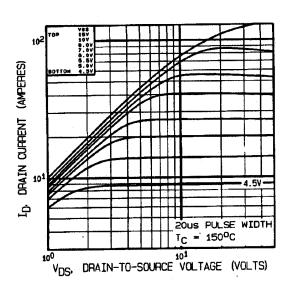


Fig 2. Typical Output Characteristics

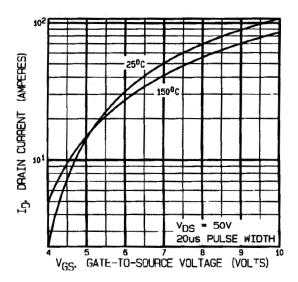


Fig 3. Typical Transfer Characteristics

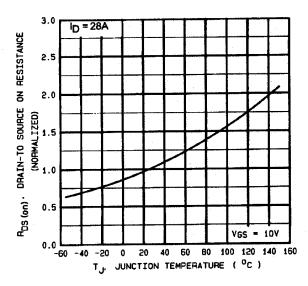
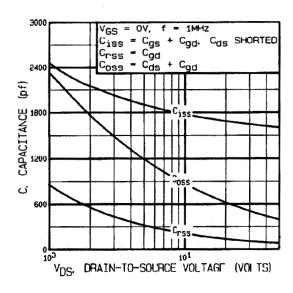


Fig 4. Normalized On-Resistance Vs. Temperature

80 V

50 V

V_{DS}

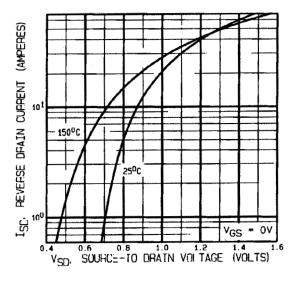


GATE-TO-SOURCE VOLTAGE (VOLTS) 16 12 ۰. ۲ FOR TEST CIRCUIT SEE FIGURE 13a & b Qg, TCTAL GATE CHARGE (nC)

ID = 28A

Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage



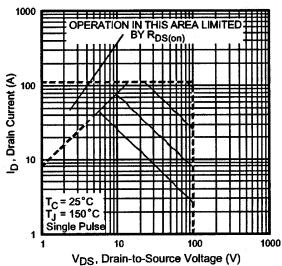


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

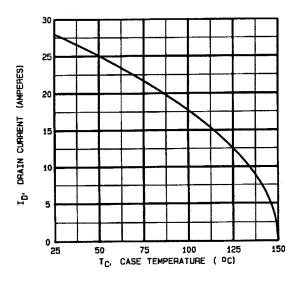


Fig 9. Maximum Drain Current Vs. Case Temperature

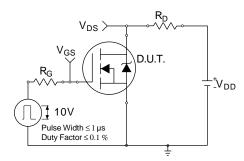


Fig 10a. Switching Time Test Circuit

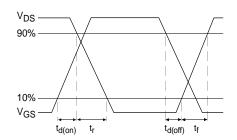


Fig 10b. Switching Time Waveforms

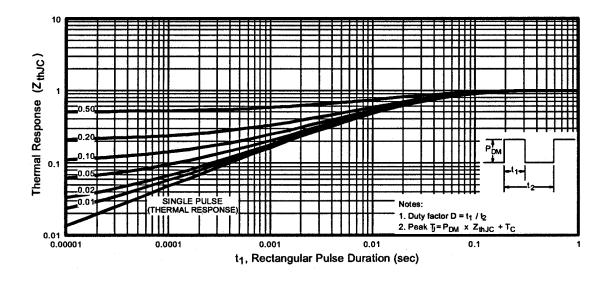


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

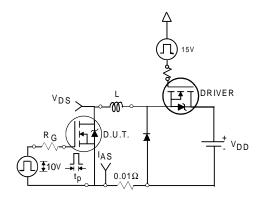


Fig 12a. Unclamped Inductive Test Circuit

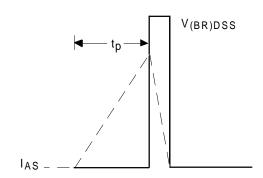


Fig 12b. Unclamped Inductive Waveforms

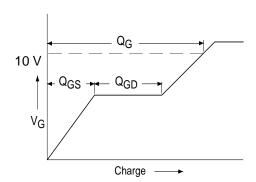


Fig 13a. Basic Gate Charge Waveform

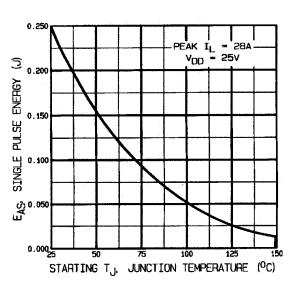


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

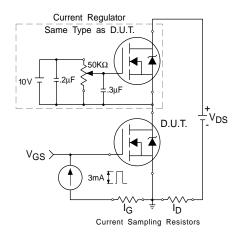


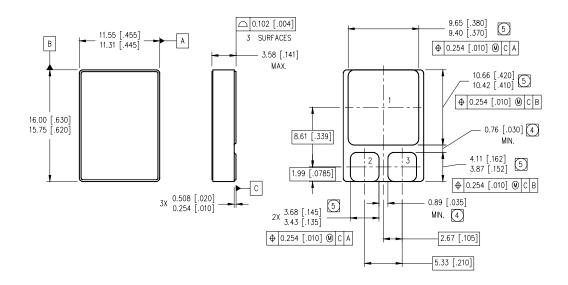
Fig 13b. Gate Charge Test Circuit

IOR Rectifier

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② VDD = 25V, starting TJ = 25°C, L= 0.64mH Peak I_L = 28A, V_GS = 10V
- ③ $I_{SD} \le 28A$, $di/dt \le 170A/\mu s$, $V_{DD} \le 100V$, $T_{J} \le 150$ °C
- 4 Pulse width $\leq 300 \ \mu s$; Duty Cycle $\leq 2\%$

Case Outline and Dimensions — SMD-1



NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: INCH.
- DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]. 3.
- DIMENSION INCLUDES METALLIZATION FLASH.
 - DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.

PAD ASSIGNMENTS

- 1-DRAIN
- 2- GATE
- 3-SOURCE



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

Visit us at www.irf.com for sales contact information. Data and specifications subject to change without notice. 01/02